Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/603,921	PAN, CHIN-CHUN	
Examiner	Art Unit	
James W. Cranson	2875	

	SEAR	CHED	
Class	Subclass	Date	Examiner
439	619	1/18/2005	JWC
362	226	1/18/2005	JWC
313	318.1	1/18/2005	JWC
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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362/\$	1/18/2005	JWC
439/\$	1/18/2005	JWC
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